## onsemi

### **MOSFET** - Power, N-Channel, PowerTrench<sup>®</sup> Power Clip, Symmetric Dual <sup>30 V</sup> NTTFD2D8N03P1E

#### Features

- Small Footprint (3.3mm x 3.3mm) for Compact Design
- Low R<sub>DS(on)</sub> to Minimize Conduction Losses
- $\bullet \ Low \ Q_G$  and Capacitance to Minimize Driver Losses
- These Devices are Pb-Free and are RoHS Compliant

#### **Typical Applications**

- DC-DC Converters
- System Voltage Rails

#### **MAXIMUM RATINGS** (T<sub>J</sub> = 25°C unless otherwise noted)

Para	neter		Symbol	Q1	Q2	Unit
Drain-to-Source Volt	age		V <sub>DSS</sub>	30	30	V
Gate-to-Source Volt	age		V <sub>GS</sub>	+16 -12	+16 -12	V
Continuous Drain Current $R_{\theta,IC}$		$T_C = 25^{\circ}C$	Ι <sub>D</sub>	80	80	А
(Note 3)	Steady	$T_C = 85^{\circ}C$		58	58	
Power Dissipation $R_{\theta JC}$ (Note 3)	State	$T_A = 25^{\circ}C$	P <sub>D</sub>	26	26	W
Continuous Drain Current $R_{\theta,IA}$		$T_A = 25^{\circ}C$	Ι <sub>D</sub>	21.1	21.1	А
(Notes 1, 3)	Steady	$T_A = 85^{\circ}C$		15.2	15.2	
Power Dissipation $R_{\theta JA}$ (Notes 1, 3)	State	$T_A = 25^{\circ}C$	PD	1.79	1.79	W
Continuous Drain		$T_A = 25^{\circ}C$	I <sub>D</sub>	16.1	16.1	А
Current R <sub>θJA</sub> (Notes 2, 3)	Steady	$T_A = 85^{\circ}C$		11.6	11.6	
Power Dissipation $R_{\theta JA}$ (Notes 2, 3)	State	$T_A = 25^{\circ}C$	P <sub>D</sub>	1.04	1.04	W
Pulsed Drain Current	T <sub>A</sub> = 25°0	C, t <sub>p</sub> = 10 μs	I <sub>DM</sub>	327	356	А
	E <sub>AS</sub>	55.4	58.8	mJ		
Operating Junction and	T <sub>J</sub> , T <sub>stg</sub>	-55 to + 150		°C		
Lead Temperature for Purposes (1/8" from			ΤL	260		°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

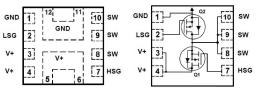
- 1. Surface-mounted on FR4 board using a 1 in<sup>2</sup> pad size, 2 oz. Cu pad.
- 2. Surface-mounted on FR4 board using minimum pad size, 2 oz. Cu pad.
- 3. The entire application environment impacts the thermal resistance values shown, they are not constants and are only valid for the particular conditions noted. Actual continuous current will be limited by thermal & electro–mechanical application board design. R<sub>0,JC</sub> is determined by the user's board design.
- 4. Q1 100% UIS tested at L = 0.1 mH, IAS = 21.1 A.

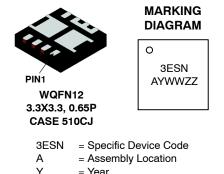
Q2 100% UIS tested at L = 0.1 mH, IAS = 21.1 A.

5. This device is Class 1B ESD HBM Rating.

FET	V <sub>(BR)DSS</sub> R <sub>DS(ON)</sub> MAX		I <sub>D</sub> MAX
Q1	30 V	$2.5~\mathrm{m}\Omega$ @ 10 V	80 A
QI	30 V	$3.0~\text{m}\Omega$ @ $4.5~\text{V}$	60 A
Q2	30 V 2.5 mΩ @ 10 V		80 A
Q2	30 V	$3.0~\text{m}\Omega$ @ $4.5~\text{V}$	60 A

#### **ELECTRICAL CONNECTION**





=	Y	ea		

ww

ΖZ

- = Work Week
  - = Assembly Lot Code

#### **ORDERING INFORMATION**

Device	Package	Shipping <sup>†</sup>
NTTFD2D8N03P1E	WQFN12 (Pb-Free)	3000 / Tape & Reel

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

#### THERMAL RESISTANCE MAXIMUM RATINGS

Parameter	Symbol	Q1 Max	Q2 Max	Unit
Junction-to-Case - Steady State (Notes 1, 3)	$R_{ heta JC}$	4.8	4.8	°C/W
Junction-to-Ambient - Steady State (Notes 1, 3)	$R_{ hetaJA}$	70	70	
Junction-to-Ambient - Steady State (Notes 2, 3)	$R_{\theta JA}$	120	120	

#### ELECTRICAL CHARACTERISTICS (T<sub>J</sub> = 25°C unless otherwise specified)

Parameter	Symbol	Test Condition	FET	Min	Тур	Max	Unit
OFF CHARACTERISTICS							

OIT ONANAOTENISTICS								
Drain-to-Source Breakdown	V <sub>(BR)DSS</sub>	$V_{GS}$ = 0 V, I <sub>D</sub> =	1 mA	Q1	30			Ň
Voltage		$V_{GS}$ = 0 V, I <sub>D</sub> =	1 mA	Q2	30		V	
Drain-to-Source Breakdown Voltage Temperature Coefficient	V <sub>(BR)DSS</sub> /	I <sub>D</sub> = 1 mA, ref to	≥25°C	Q1		17.9		mV/°C
	١J	$I_D = 1 \text{ mA}, \text{ ref to } 25^{\circ}\text{C}$		Q2		17.2		mv/°C
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	$V_{GS} = 0 V,$	$T_J = 25^{\circ}C$	Q1			1.0	
		V <sub>DS</sub> = 24 V		Q2			1.0	μΑ
Gate-to-Source Leakage Current	I <sub>GSS</sub>	$V_{DS} = 0 V, V_{GS} = +1$	6 V / -12 V	Q1			±100	-
		V <sub>DS</sub> = 0 V, V <sub>GS</sub> = +1	6 V / –12 V	Q2	=		±100	nA

#### **ON CHARACTERISTICS** (Note 6)

Gate Threshold Voltage	V <sub>GS(TH)</sub>	$V_{GS} = V_{DS}$ , $I_D = 400 \ \mu A$	Q1	1.2		2.2	V
		$V_{GS} = V_{DS}$ , $I_D = 400 \ \mu A$	Q2	1.2		2.2	v
Negative Threshold Temperature Coefficient	$V_{GS(TH)}/T_J$	$I_D = 400 \ \mu A$ , ref to $25^{\circ}C$	Q1		-4.3		
		$I_D = 400 \ \mu A$ , ref to $25^{\circ}C$	Q2		-4.5		mV/°C
Drain-to-Source On Resistance	R <sub>DS(on)</sub>	$V_{GS}$ = 10 V, I <sub>D</sub> = 18 A	Q1		2.0	2.5	
		$V_{GS}$ = 4.5 V, I <sub>D</sub> = 16 A			2.6	3.0	<b>m</b> ()
		$V_{GS}$ = 10 V, I <sub>D</sub> = 18 A	Q2		1.8	2.5	mΩ
		$V_{GS}$ = 4.5 V, I <sub>D</sub> = 16 A			2.4	3.0	
Forward Transconductance	9fs	$V_{DS} = 5 V, I_{D} = 18 A$	Q1		129		0
		$V_{DS} = 5 V, I_{D} = 18 A$	Q2		141		S
Gate-Resistance	R <sub>G</sub>	$T_A = 25^{\circ}C$	Q1		0.68		0
			Q2		0.75		Ω

#### **CHARGES, CAPACITANCES & GATE RESISTANCE**

Input Capacitance	C <sub>ISS</sub>		Q1	1500	рF
			Q2	1521	рі
Output Capacitance	C <sub>OSS</sub>		Q1	483	рF
		V <sub>GS</sub> = 0 V, V <sub>DS</sub> = 15 V, f = 1 MHz	Q2	498	pΓ
Reverse Transfer Capacitance	C <sub>RSS</sub>		Q1	29	ρF
			Q2	22	рг

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions. 6. Pulse Test: pulse width  $\leq 300 \ \mu$ s, duty cycle  $\leq 2\%$ .

7. Switching characteristics are independent of operating junction temperatures.

#### **ELECTRICAL CHARACTERISTICS** (T<sub>J</sub> = $25^{\circ}$ C unless otherwise specified)

Parameter	Symbol	Test Condition	FET	Min	Тур	Max	Unit		
CHARGES, CAPACITANCES & GATE RESISTANCE									
Total Gate Charge	Q <sub>G(TOT)</sub>		Q1		9.5		nC		
			Q2		9.3		no		
Gate-to-Drain Charge	Q <sub>GD</sub>	$ \begin{array}{c} \mathbf{Q}_{GD} \\ \mathbf{Q}_{1}:  \mathbf{V}_{GS} = 4.5  \text{V},  \mathbf{V}_{DS} = 15  \text{V};  \mathbf{I}_{D} = 18  \text{A} \\ \mathbf{Q}_{2}:  \mathbf{V}_{GS} = 4.5  \text{V},  \mathbf{V}_{DS} = 15  \text{V};  \mathbf{I}_{D} = 18  \text{A} \end{array} $	Q1		2.0		nC		
			Q2		1.6		no		
Gate-to-Source Charge	Q <sub>GS</sub>		Q1		3.7		nC		
			Q2		3.7		no		
Total Gate Charge	Q <sub>G(TOT)</sub>	Q1: $V_{GS}$ = 10 V, $V_{DS}$ = 15 V; $I_{D}$ = 18 A	Q1		20.8		nC		
		Q2: $V_{GS}$ = 10 V, $V_{DS}$ = 15 V; $I_{D}$ = 18 A	Q2		20.5		nc		

#### SWITCHING CHARACTERISTICS, VGS = 4.5 V (Note 7)

Turn-On Delay Time	t <sub>d(ON)</sub>		Q1	13	20
			Q2	13.3	ns
Rise Time	tr	$V_{GS}$ = 4.5 V Q1: I <sub>D</sub> = 18 A, V <sub>DD</sub> = 15 V, R <sub>G</sub> = 6 Ω Q2: I <sub>D</sub> = 18 A, V <sub>DD</sub> = 15 V, R <sub>G</sub> = 6 Ω	Q1	5.5	20
			Q2	5.8	ns
Turn-Off Delay Time	t <sub>d(OFF)</sub>	Q2: $I_D = 18 \text{ A}, V_{DD} = 15 \text{ V}, H_G = 6 \Omega$	Q1	18.9	20
			Q2	19	ns
Fall Time	t <sub>f</sub>		Q1	5.5	20
		F	Q2	5.5	ns

#### SWITCHING CHARACTERISTICS, VGS = 10 V (Note 7)

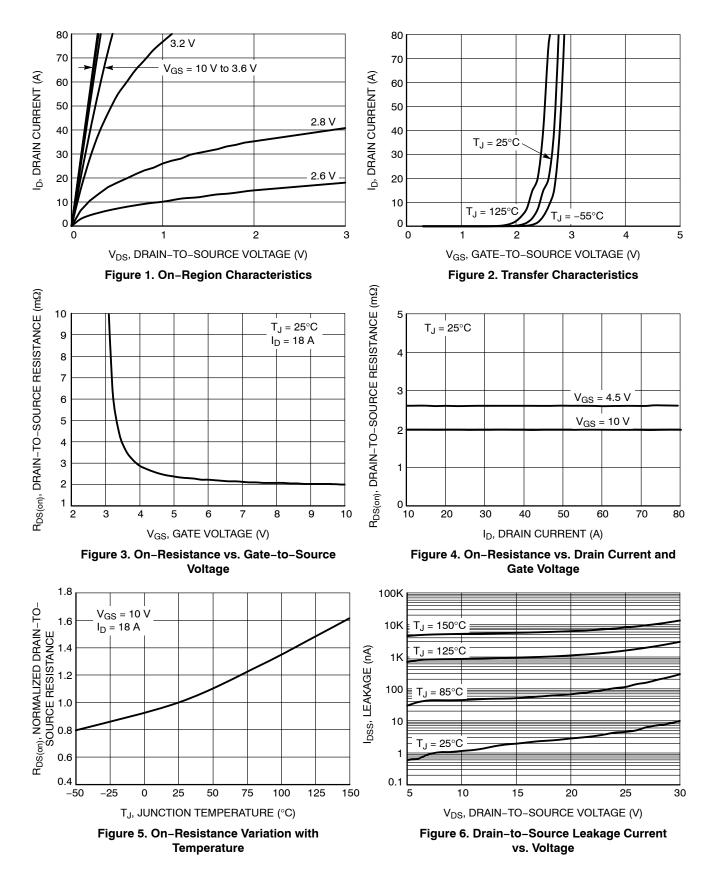
Turn-On Delay Time	t <sub>d(ON)</sub>		Q1	8.4	20	
			Q2	8.7	ns	
Rise Time	t <sub>r</sub>		Q1	2	20	
		$V_{GS} = 10 \text{ V}$ Q1: I <sub>D</sub> = 18 A, V <sub>DD</sub> = 15 V, R <sub>G</sub> = 6 $\Omega$	Q2	2	ns	
Turn-Off Delay Time	t <sub>d(OFF)</sub>	Q1. ID = 18 A, $V_{DD}$ = 15 V, $R_{G}$ = 0 $\Omega$ Q2: I <sub>D</sub> = 18 A, $V_{DD}$ = 15 V, $R_{G}$ = 6 $\Omega$	Q1	26.3		
		Q2	26.3	ns		
Fall Time	t <sub>f</sub>		Q1	3.8	20	
		F	Q2	3.6	ns	

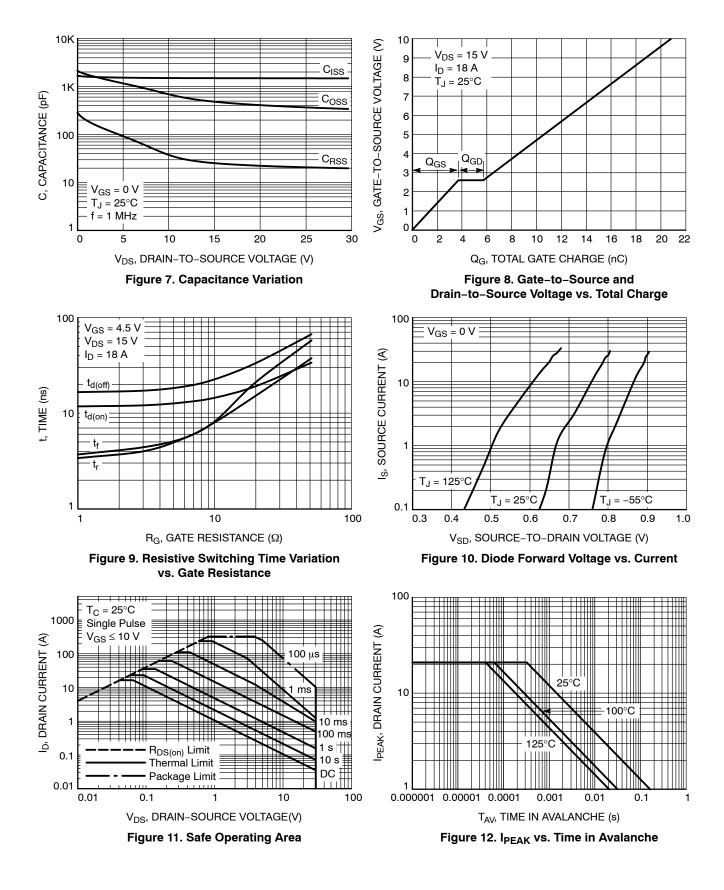
#### DRAIN-SOURCE DIODE CHARACTERISTICS

Forward Diode Voltage Vs	V <sub>SD</sub>	V <sub>GS</sub> = 0 V,	$T_J = 25^{\circ}C$	Q1	0.8	1.2	
		I <sub>S</sub> = 18 A	T <sub>J</sub> = 125°C		0.67		V
		V <sub>GS</sub> = 0 V, I <sub>S</sub> = 18 A	$T_J = 25^{\circ}C$	Q2	0.8	1.2	v
		I <sub>S</sub> = 18 A	T <sub>J</sub> = 125°C		0.66		
Reverse Recovery Time	t <sub>RR</sub>	V <sub>GS</sub> = 0 V, V <sub>DD</sub> = 15 V Q1: I <sub>S</sub> = 18 A, dI <sub>S</sub> /dt = 100 A/µs		Q1	30		ns
				Q2	29		
Reverse Recovery Charge	Q <sub>RR</sub>	Q2: $I_S = 18 \text{ A}, dI_S/dt$	= 100 A/μs = 100 A/μs	Q1	13		nC
				Q2	12.5		

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

6. Pulse Test: pulse width  $\leq 300 \ \mu$ s, duty cycle  $\leq 2\%$ . 7. Switching characteristics are independent of operating junction temperatures.





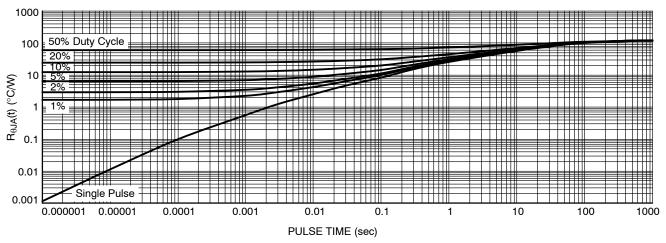
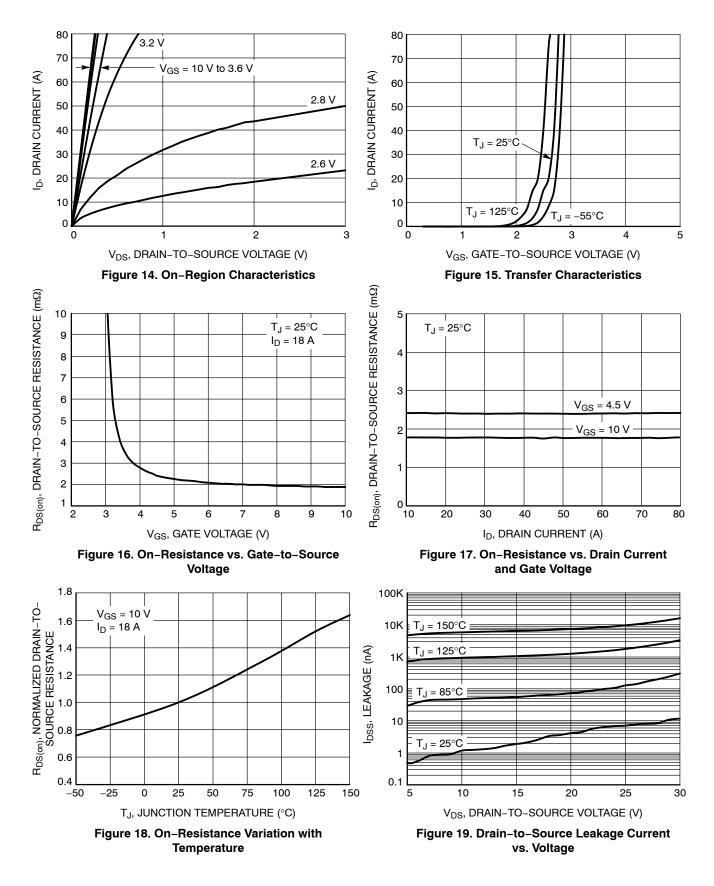
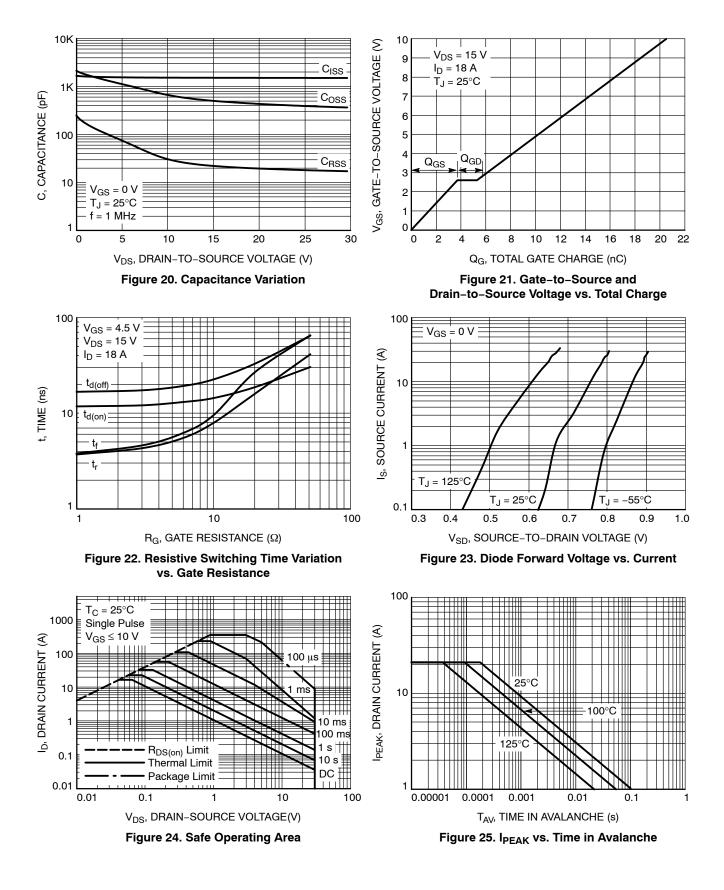


Figure 13. Thermal Characteristics





#### **TYPICAL CHARACTERISTICS – Q2**

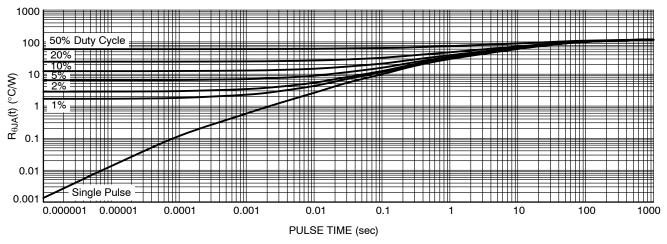


Figure 26. Thermal Characteristics

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# DUSEM

NOM

0.75

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0.20 REF

0.32

3.30

1.44

0.20

3.30

1.19

0.30

0.65 BSC

0.325 BSC

1.24 BSC

0.33 REF

0.43 REF

0.54

0.29

0.25

MAX

0.80

0.05

0.37

3.40

1.54

0.30

3.40

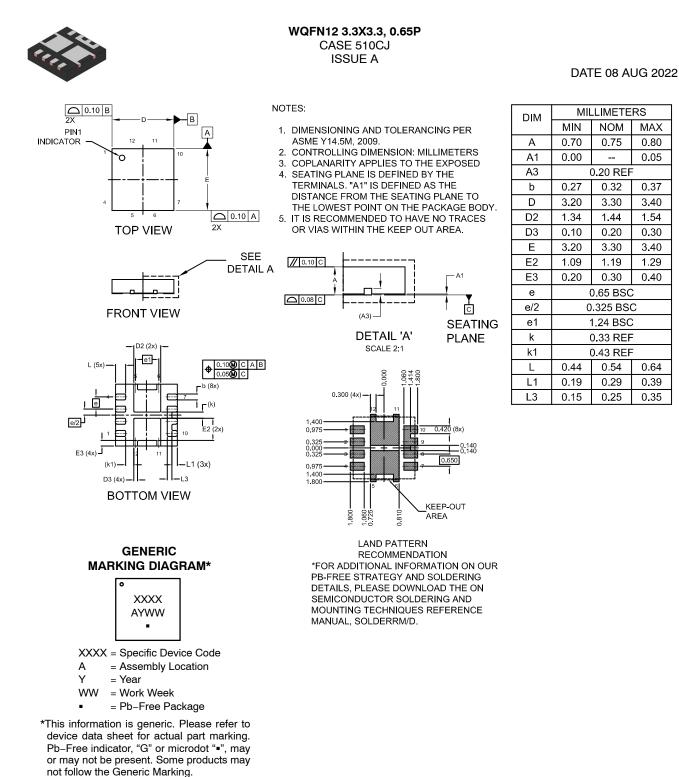
1.29

0.40

0.64

0.39

0.35



DESCRIPTION:	WQFN12 3.3X3.3, 0.65P	•	PAGE 1 OF 1

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